


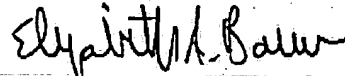
Applicant	James D. Beasom
Serial No.	10/033,156
Filing Date	October 25, 2001
Group Art Unit	2811
Examiner Name	Thomas J. Magee
Confirmation No.	7041
Facsimile No.	703-872-9306
Attorney Docket No.	125.020US01
Title: SEALED NITRIDE LAYER FOR INTEGRATED CIRCUITS	

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Attention: Examiner Thomas J. Magee, Art Unit 2811

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Enclosures					
The following documents are enclosed:					
<input checked="" type="checkbox"/> Amendment and Response Under 37 C.F.R. 1.111 (12 pgs.).					
Submitted By					
Name	Scott V. Lundberg	Reg.No.	41,958	Telephone	(612) 332-4720
Signature				Date	June 1, 2004
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Certificate of Transmission					
I certify that this paper, and the above-identified documents, are being transmitted by facsimile to, Examiner Thomas J. Magee, Group Art Unit 2811 (Facsimile No. 703-872-9306) of the United States Patent and Trademark Office on June 1, 2004.					
Name	Elizabeth A. Bauer		Signature		

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**AMENDMENT
AND RESPONSE
UNDER 37 C.F.R. § 1.111**

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Commissioner for Patents
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Applicants have reviewed the Office Action mailed on March 1, 2004. Please amend the above-identified application as follows.

Amendments to the Claims are reflected in the listing of claims that begins on page 2 of this paper.

Remarks begin on page 6 of this paper.